ISO/IEC 18047-2:2012-01 (E)

Information technology - Radio frequency identification device conformance test methods - Part 2: Test methods for air interface communications below 135 kHz

Contents

Page

Foreword v

Introduction vi

1 Scope 1

2 Normative references 1

3 Terms, definitions, symbols and abbreviated terms 2
3.1 Terms and definitions 2
3.2 Symbols 2
3.3 Abbreviated terms 2

4.1 General 3
4.2 Default conditions applicable to the test methods 3
4.2.1 Test environment 3
4.2.2 Pre-conditioning 3
4.2.3 Default tolerance 3
4.2.4 Spurious inductance 3
4.2.5 Noise floor at test location 3
4.2.6 Total measurement uncertainty 3
4.3 Setup of test equipment for tag tests 4
4.3.1 Parameter definition 4
4.3.2 Test equipment configuration 4
4.4 Test methods for tags 11
4.4.1 Tag Orientation 11
4.5 Test procedure for tags 11
4.5.1 Calibrating null compensation 11
4.5.2 Minimum activating magnetic field strength in FDX mode 13
4.5.3 Minimal activating magnetic field strength in HDX mode 13
4.5.4 Level of tag response in FDX mode 14
4.5.5 Level of tag response in HDX mode 15
4.5.6 Tag waiting time for FDX mode 16
4.5.7 Tag waiting time for HDX mode 16
4.6 Equipment for interrogator tests 17
4.6.1 Tag Emulation Circuit 17
4.7 Methods for interrogator tests 17
4.7.1 Verification of reading 17
4.7.2 Tag Orientation 17
4.8 Test procedure for interrogator 18
4.8.1 Modulation index and waveform 18
4.8.2 Power generation for FDX (informative) 18
4.8.3 Power generation for HDX (informative) 19
4.8.4 Response detection for FDX 19
4.8.5 Response detection for HDX 19

Annex A (normative) Design description of the tag emulation circuits 20

A.1 Reference air-cored antenna 20
A.2 FDX Tag Emulation Circuit 20
A.2.1 General 20

A.2.2 Set up trimming 22
A.3 The HDX Tag Emulation Circuit 22
A.3.1 General 22
A.3.2 Working principle of the HDX Tag Emulation Circuit 23
A.3.3 Set up and trimming procedure for the HDX emulation 23

Annex B (informative) Program for the evaluation of the spectrum 25

Bibliography 29